# FAIRCHILD

SEMICONDUCTOR®

# FDD5810\_F085 N-Channel Logic Level Trench<sup>®</sup> MOSFET 60V, 36A, 27m $\Omega$

## **Features**

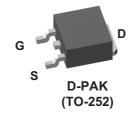
- $R_{DS(ON)} = 22m\Omega$  (Typ.),  $V_{GS} = 5V$ ,  $I_D = 29A$
- Q<sub>g(5)</sub> = 13nC (Typ.), V<sub>GS</sub> = 5V
- Low Miller Charge
- Low Q<sub>rr</sub> Body Diode
- UIS Capability (Single Pulse / Repetitive Pulse)
- Qualified to AEC Q101
- RoHS Compliant

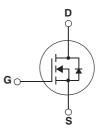
## **Applications**

- Motor / Body Load Control
- ABS Systems
- Powertrain Management
- Injection System
- DC-DC converters and Off-line UPS
- Distributed Power Architecture and VRMs
- Primary Switch for 12V and 24V systems



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FDD5810\_F085 N-Channel Logic Level Trench<sup>®</sup> MOSFET

May 2010

Symbol		Parameter				Ratings	Units	
V <sub>DSS</sub>	Drain to S	ource Voltage				60	V	
V <sub>GS</sub>	Gate to So	Gate to Source Voltage				±20	V	
		rent Continuous (V <sub>GS</sub> = 10 <sup>v</sup>			37			Α
I <sub>D</sub>		rent Continuous (V <sub>GS</sub> = 5V			33			A
טי	Continuou	is $(T_A = 25^{\circ}C, V_{GS} = 10V, V_{CS})$	with $R_{\theta JA} = 52^{\circ}C$	C/W)	7.4			A
	Pulsed						A	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 1)					45		
PD	Power Dis				72			W/ºC
_	_	Derate above 25°C				0.48		
T <sub>J</sub> , T <sub>STG</sub>	Operating	and Storage Temperature			-55 to 175			°C
Therma	I Charao	cteristics						
R <sub>θJC</sub>	Maximum Thermal resistance Junction to Case TO-252					2.1		°C/W
R <sub>θJA</sub>	Thermal F	Resistance Junction to Amb	ient TO-252, 1in	<sup>2</sup> copper pad area		52		°C/W
Device		ng and Ordering	Informatio	n Reel Size	Tape V	Vidth	Qua	ntitv
FDD		FDD5810 F085	TO-252AA	330mm		mm	2500 units	
Symbol		Parameter	Test	Conditions	Min	Тур	Мах	Unite
		-	050 4	N 01/		i		V
B <sub>VDSS</sub>	Drain to S	ource Breakdown Voltage	I <sub>D</sub> = 250μA, V <sub>DS</sub> = 48V	$V_{GS} = 0V$	60	-	- 1	V
I <sub>DSS</sub>	Zero Gate	Zero Gate Voltage Drain Current		$T_{\rm C} = 150^{\rm o}{\rm C}$	-	-	250	μA
I <sub>GSS</sub>	Gate to Sc	ource Leakage Current	$V_{GS} = 0V$ $V_{GS} = \pm 20V$			-	±100	nA
			165		-			
On Chara	octeristics	6						
V <sub>GS(TH)</sub>	I <sub>D</sub> = 32A, V		$V_{GS} = V_{DS},$	I <sub>D</sub> = 250μA	1	1.6	2	V
0.0(11)			I <sub>D</sub> = 32A, V <sub>C</sub>		-	18	22	
R <sub>DS(ON)</sub>			I <sub>D</sub> = 29A, V <sub>C</sub>	I <sub>D</sub> = 29A, V <sub>GS</sub> = 5V		22	27	mΩ
US(ON)	Dianito			I <sub>D</sub> = 32A, V <sub>GS</sub> = 10V,		43	53	1112.2
			T <sub>J</sub> = 175 <sup>o</sup> C					
								_
Dynamic	Characte	ristics					1890	pF
C <sub>iss</sub>	Characte Input Capa		V 25V	V 0V	-	1420	1690	
C <sub>iss</sub>	Input Capa Output Ca	acitance pacitance	$V_{DS} = 25V, V_{DS} = 100$	V <sub>GS</sub> = 0V,	-	1420 150	200	pF
-	Input Capa Output Ca	acitance	f = 1MHz	V <sub>GS</sub> = 0V,				pF pF
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>G</sub>	Input Capa Output Ca Reverse T Gate Resi	acitance pacitance iransfer Capacitance stance	f = 1MHz f = 1MHz			150	200	
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>G</sub> Q <sub>g</sub>	Input Capa Output Ca Reverse T Gate Resis Total Gate	acitance pacitance iransfer Capacitance stance 9 Charge at 10V	$f = 1MHz$ $f = 1MHz$ $V_{GS} = 0V to$	10V	-	150 65	200 100 - 34	pF
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>G</sub> Q <sub>g</sub> Q <sub>g</sub>	Input Capa Output Ca Reverse T Gate Resis Total Gate Total Gate	acitance pacitance ransfer Capacitance stance • Charge at 10V • Charge at 5V	$f = 1MHz$ $f = 1MHz$ $V_{GS} = 0V \text{ to}$ $V_{GS} = 0V \text{ to}$	10V 5V	-	150 65 3.5 24 13	200 100 -	pF Ω nC nC
$C_{iss}$ $C_{oss}$ $C_{rss}$ $R_{G}$ $Q_{g}$ $Q_{g}$ $Q_{g(th)}$	Input Capa Output Ca Reverse T Gate Resi Total Gate Total Gate Threshold	acitance pacitance ransfer Capacitance stance charge at 10V charge at 5V Gate Charge	$f = 1MHz$ $f = 1MHz$ $V_{GS} = 0V \text{ to}$	$\frac{10V}{5V}$ $V_{DD} = 30V$		150 65 3.5 24 13 1.3	200 100 - 34	pF Ω nC
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub> R <sub>G</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>g(th)</sub> Q <sub>gs</sub>	Input Capa Output Ca Reverse T Gate Resi Total Gate Total Gate Threshold Gate to So	acitance pacitance ransfer Capacitance stance charge at 10V charge at 5V Gate Charge purce Gate Charge	$f = 1MHz$ $f = 1MHz$ $V_{GS} = 0V \text{ to}$ $V_{GS} = 0V \text{ to}$	10V 5V		150 65 3.5 24 13 1.3 4.0	200 100 - 34 18	pF Ω nC nC
$C_{iss}$ $C_{oss}$ $C_{rss}$ $R_{G}$ $Q_{g}$ $Q_{g}$ $Q_{g(th)}$	Input Capa Output Ca Reverse T Gate Resis Total Gate Total Gate Threshold Gate to Sc Gate Char	acitance pacitance ransfer Capacitance stance charge at 10V charge at 5V Gate Charge	$f = 1MHz$ $f = 1MHz$ $V_{GS} = 0V \text{ to}$ $V_{GS} = 0V \text{ to}$	$\frac{10V}{5V}$ $V_{DD} = 30V$	- - - -	150 65 3.5 24 13 1.3	200 100 - 34 18 -	pF Ω nC nC nC

Switch	Switching Characteristics						
t <sub>on</sub>	Turn-On Time		-	-	130	ns	
t <sub>d(on)</sub>	Turn-On Delay Time		-	12	-	ns	
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 30V, I <sub>D</sub> = 35A	-	75	-	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{DD} = 30V, I_D = 35A$ $V_{GS} = 5V, R_{GS} = 11\Omega$	-	26	-	ns	
t <sub>f</sub>	Fall Time		-	34	-	ns	
t <sub>off</sub>	Turn-Off Time		-	-	90	ns	
	<b>I</b>						

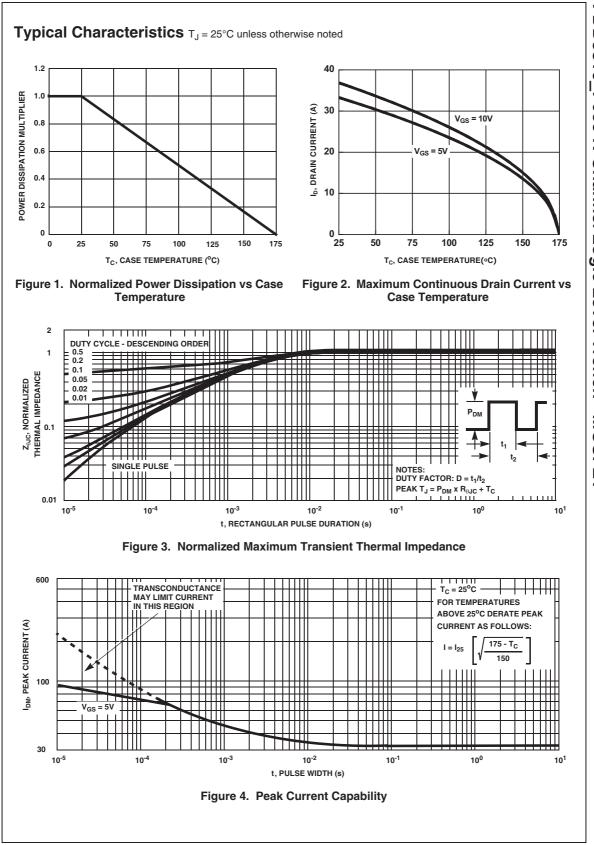
### **Drain-Source Diode Characteristics**

Drain-	Source Diode Characteristics					
V <sub>SD</sub>	Source to Drain Diode Voltage	I <sub>SD</sub> = 32A	-	-	1.25	V
		I <sub>SD</sub> = 16A	-	-	1.0	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 35A, di/dt = 100A/μs	-	-	39	ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 35A, di/dt = 100A/μs	-	-	35	nC

Notes: 1: Starting TJ = 25°C, L = 110 $\mu$ H, Ias = 28A, V<sub>DD</sub> = 54V, V<sub>GS</sub> = 10V.

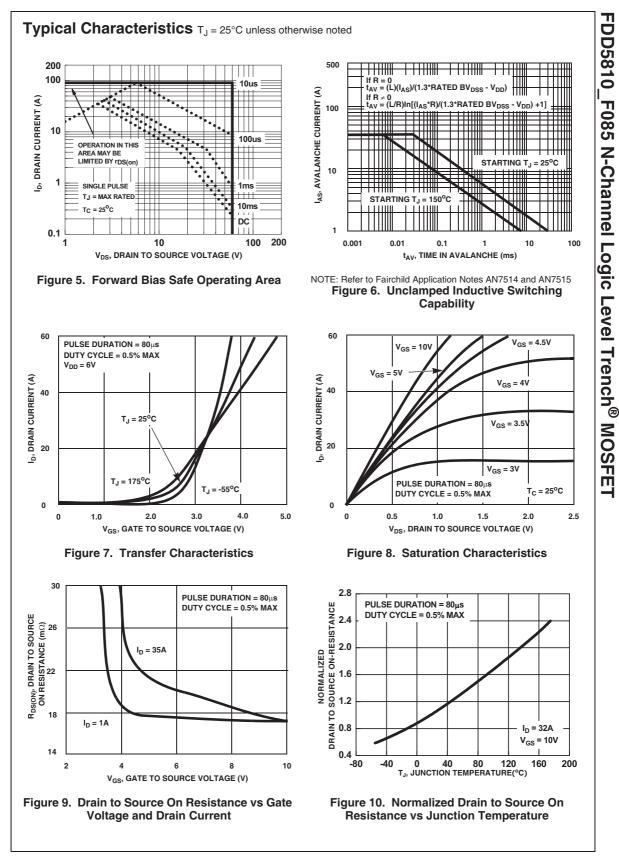
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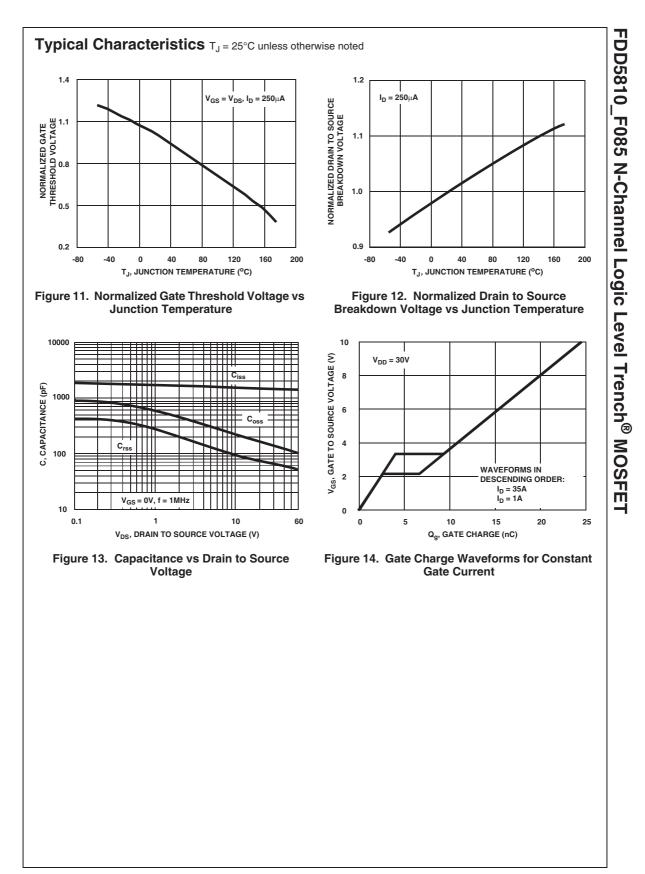
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